## Application/Control No. Applicant(s)/Patent Under Reexamination 10/621,882 TAKIAR, HÉM P. Notice of References Cited Examiner Art Unit Page 1 of 1 3729 Rick K. Chang **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-7,094,633 B2 08-2006 Takiar, Hem P. 438/113 Α US-В UŞ-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ L US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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